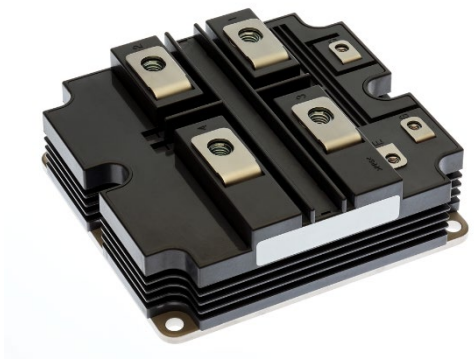
MITSUBISHI ELECTRIC

< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM600HG-130X

HIGH POWER SWITCHING USE
INSULATED TYPE 5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

CM600HG-130X

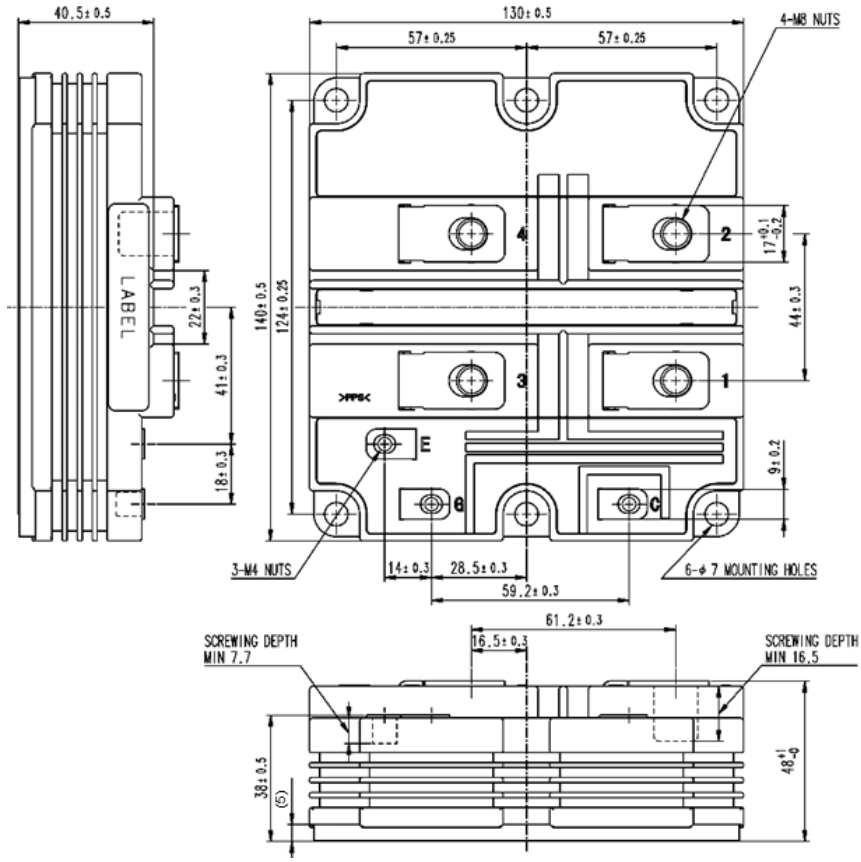


- I_C ..... 600 A
- V_{CES} ..... 6500 V
- 1-element in a Pack
- Insulated Type
- CSTBT™(III)
- RFC Diode
- AlSiC Baseplate

APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

OUTLINE DRAWING & CIRCUIT DIAGRAM **Dimensions in mm**



接続図
CIRCUIT DIAGRAM

CM600HG-130X

HIGH POWER SWITCHING USE
INSULATED TYPE 5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor)

MAXIMUM RATINGS (T_j=25°C, unless otherwise specified)

Symbol	Item	Conditions	Ratings	Unit
V_{CES}	Collector-emitter voltage	V_{GE} = 0V, T_j = +150°C	6500	V
		V_{GE} = 0V, T_j = +25°C	6300	
		V_{GE} = 0V, T_j = −50°C	5700	
V_{GES}	Gate-emitter voltage	V_{CE} = 0V, T_j = 25°C	±20	V
I_C	Collector current	DC, T_C = 110°C	600	A
I_{CRM}		Pulse (Note 1)	1200	A
I_E	Emitter current (Note 2)	DC, T_C = 95°C	600	A
I_{ERM}		Pulse (Note 1)	1200	A
P_{tot}	Maximum power dissipation (Note 3)	T_C = 25°C, IGBT part	8300	W
V_{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1min.	10200	V
Q_{pd}	Partial discharge	V1 = 6900Vrms, V2 = 5100Vrms 60Hz	10	pC
T_j	Junction temperature	—	−50 ~ +150	°C
T_{jop}	Operating junction temperature	—	−50 ~ +150	°C
T_{stg}	Storage temperature	—	−55 ~ +150	°C
t_{psc}	Short circuit pulse width	V_{CC} = 4500V, V_{CE} ≤ V_{CES}, V_{GE} = ±15V T_j = 150°C	10	µs

ELECTRICAL CHARACTERISTICS (T_j=25°C, unless otherwise specified)

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{CES}	Collector cutoff current	V_{CE} = V_{CES}, V_{GE} = 0V	T_j = 25°C	—	—	4.0	mA
			T_j = 125°C	—	3.5	—	
			T_j = 150°C	—	—	100	
$V_{GE(th)}$	Gate-emitter threshold voltage	V_{CE} = 10V, I_C = 60mA, T_j = 25°C		6.5	7.0	7.5	V
I_{GES}	Gate leakage current	V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25°C		-0.5	—	0.5	µA
C_{ies}	Input capacitance	V_{CE} = 10V, V_{GE} = 0V, f = 100kHz T_j = 25°C		—	101	—	nF
C_{oes}	Output capacitance			—	4.1	—	
C_{res}	Reverse transfer capacitance			—	0.5	—	
Q_G	Total gate charge	V_{CC} = 3600V, I_C = 600A V_{GE} = ±15V, T_j = 25°C		—	6.6	—	µC
V_{CEsat}	Collector-emitter saturation voltage	I_C = 600A (Note 4) V_{GE} = 15V	T_j = 25°C	—	2.50	—	V
			T_j = 125°C	—	3.20	—	
			T_j = 150°C	—	3.30	3.80	
$t_{d(on)}$	Turn-on delay time	V_{CC} = 3600V I_C = 600A V_{GE} = ±15V $R_{G(on)}$ = 6.2Ω L_S = 225nH Inductive load	T_j = 150°C	—	—	1.45	µs
t_r	Rise time		T_j = 150°C	—	—	0.50	µs
$E_{on(10\%)}$	Turn-on switching energy (Note 7) (per pulse)		T_j = 25°C	—	4.15	—	J
			T_j = 125°C	—	4.50	—	
			T_j = 150°C	—	5.10	—	
E_{on}	Turn-on switching energy (Note 5) (per pulse)		T_j = 25°C	—	4.40	—	J
			T_j = 125°C	—	4.85	—	
			T_j = 150°C	—	5.50	—	
$t_{d(off)}$	Turn-off delay time	V_{CC} = 3600V I_C = 600A V_{GE} = ±15V $R_{G(off)}$ = 45Ω L_S = 225nH Inductive load	T_j = 25°C	—	5.90	—	µs
			T_j = 125°C	—	7.00	—	
			T_j = 150°C	—	7.00	10.5	
t_f	Fall time		T_j = 25°C	—	0.40	—	µs
			T_j = 125°C	—	0.80	—	
			T_j = 150°C	—	0.80	—	
$E_{off(10\%)}$	Turn-off switching energy (Note 7) (per pulse)		T_j = 25°C	—	2.40	—	J
			T_j = 125°C	—	3.85	—	
			T_j = 150°C	—	4.00	—	
E_{off}	Turn-off switching energy (Note 5) (per pulse)		T_j = 25°C	—	2.55	—	J
			T_j = 125°C	—	4.10	—	
			T_j = 150°C	—	4.25	—	

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
V_{EC}	Emitter-collector voltage (Note 2)	I_E = 600A (Note 4) V_{GE} = 0V	T_j = 25°C	—	2.50	—	V
			T_j = 125°C	—	3.20	—	
			T_j = 150°C	—	3.30	3.80	
t_{rr}	Reverse recovery time (Note 2)	V_{CC} = 3600V I_E = 600A V_{GE} = ±15V $R_{G(on)}$ = 6.2Ω L_S = 225nH Inductive load	T_j = 25°C	—	1.70	—	μs
			T_j = 125°C	—	2.05	—	
			T_j = 150°C	—	2.15	—	
I_{rr}	Reverse recovery current (Note 2)		T_j = 25°C	—	950	—	A
			T_j = 125°C	—	900	—	
			T_j = 150°C	—	900	—	
$Q_{rr(10\%)}$	Reverse recovery charge (Note 2,6)		T_j = 25°C	—	1200	—	μC
			T_j = 125°C	—	1550	—	
			T_j = 150°C	—	1600	—	
Q_{rr}	Reverse recovery charge (Note 2,5)		T_j = 25°C	—	1200	—	μC
			T_j = 125°C	—	1550	—	
			T_j = 150°C	—	1650	—	
$E_{rec(10\%)}$	Reverse recovery energy (Note 2,7) (per pulse)		T_j = 25°C	—	2.35	—	J
			T_j = 125°C	—	3.40	—	
			T_j = 150°C	—	3.65	—	
E_{rec}	Reverse recovery energy (Note 2,5) (per pulse)		T_j = 25°C	—	2.50	—	J
			T_j = 125°C	—	3.60	—	
			T_j = 150°C	—	4.00	—	

THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance	Junction to Case, IGBT part	—	—	15.0	K/kW
$R_{th(j-c)D}$		Junction to Case, FWDi part	—	—	24.0	K/kW
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink λ_{grease} = 1W/m·K, $D_{(c-s)}$ = 80μm	—	7.5	—	K/kW

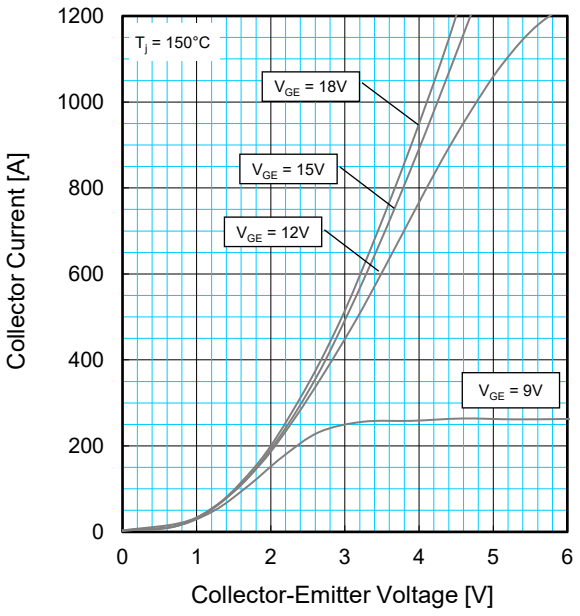
MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting torque	Main terminals screw: M8	7.0	—	19.0	N·m
M_s		Mounting screw: M6	3.0	—	6.0	N·m
M_t		Auxiliary terminals screw: M4	1.0	—	3.0	N·m
m	Mass	—	—	1.0	—	kg
CTI	Comparative tracking index	—	600	—	—	—
d_a	Clearance	—	26.0	—	—	mm
d_s	Creepage distance	—	56.0	—	—	mm
$L_{P(C-E)}$	Parasitic stray inductance	—	—	20.5	—	nH
$R_{CC'+EE'}$	Internal lead resistance	T_C = 25°C	—	0.18	—	mΩ

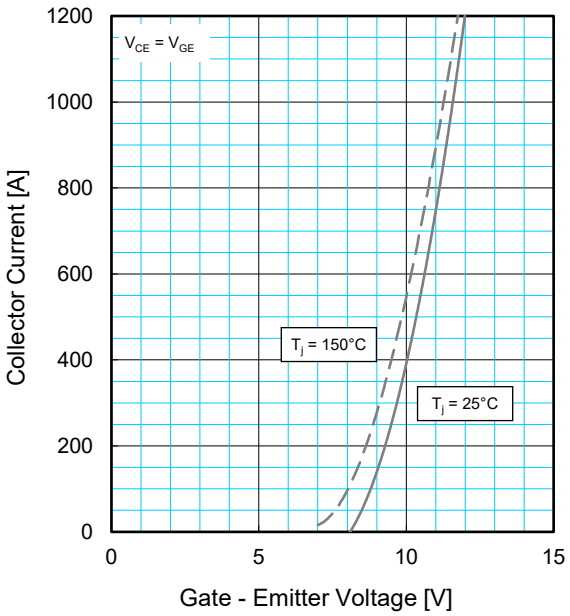
Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.
Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).
Note3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).
Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
Note5. Definition of all items is according to IEC 60747, unless otherwise specified.
Note6. The integration range of reverse recovery charge is from I_E = 0A to 10%I_E.
Note7. The integration range of switching energies is from 10%V_{CE} to 10%I_C(I_E).

PERFORMANCE CURVES

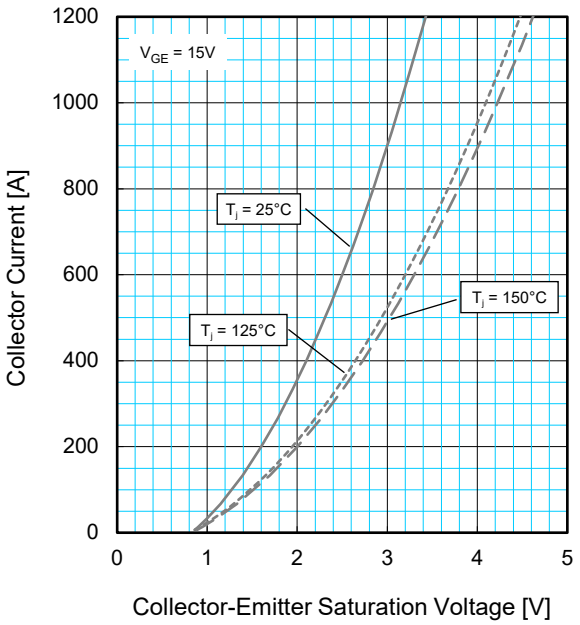
OUTPUT CHARACTERISTICS (TYPICAL)



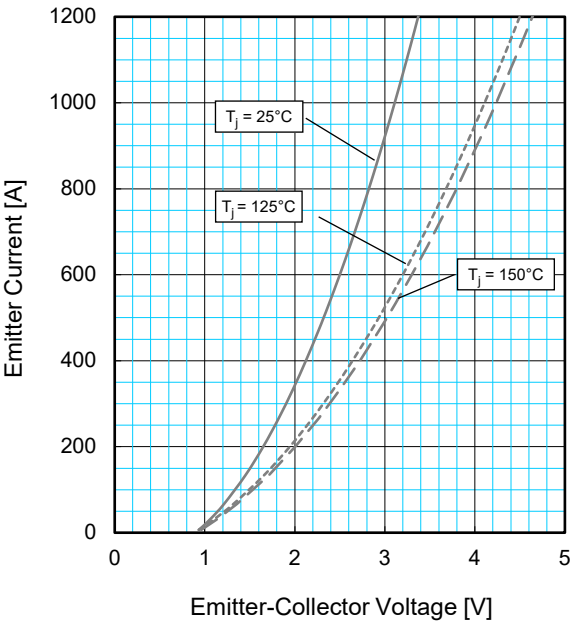
TRANSFER CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

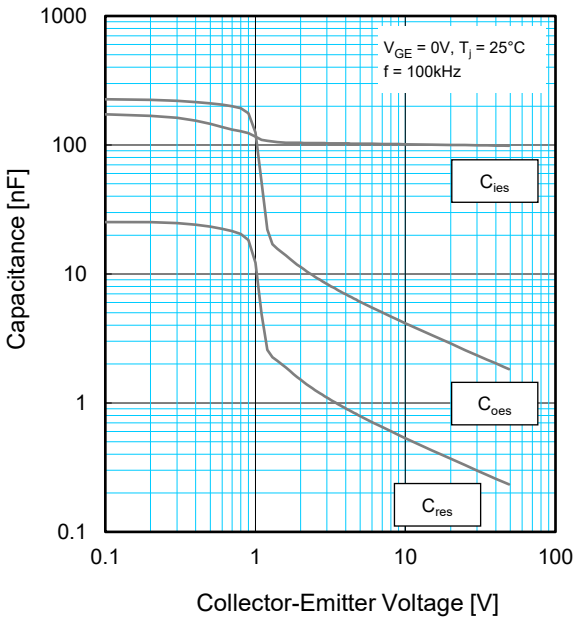


FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

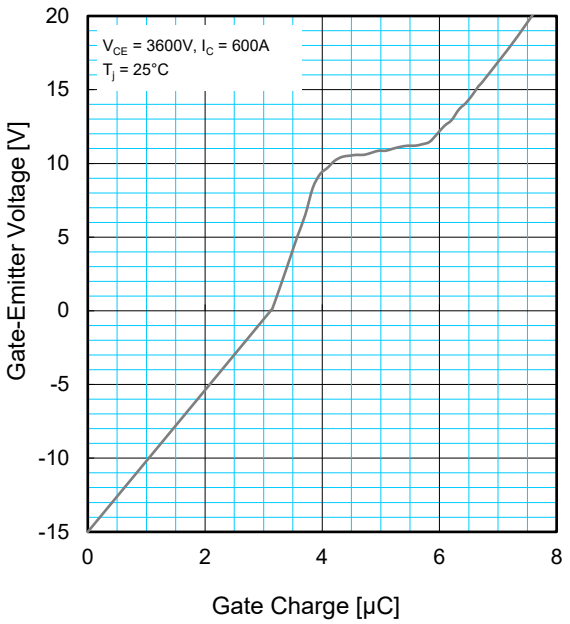


PERFORMANCE CURVES

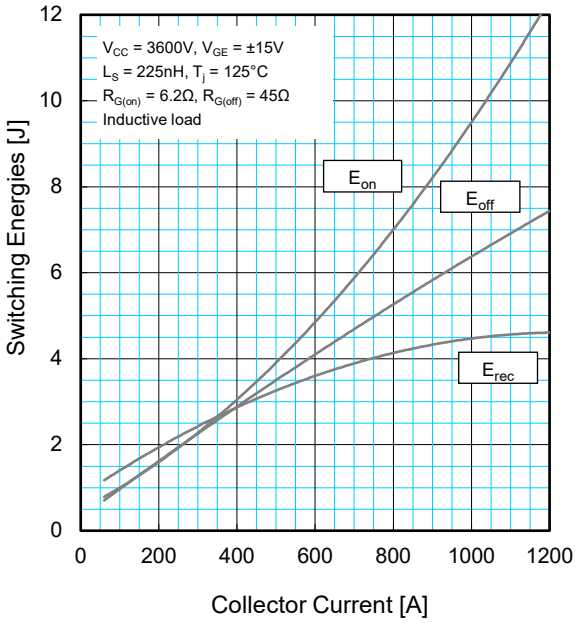
CAPACITANCE CHARACTERISTICS (TYPICAL)



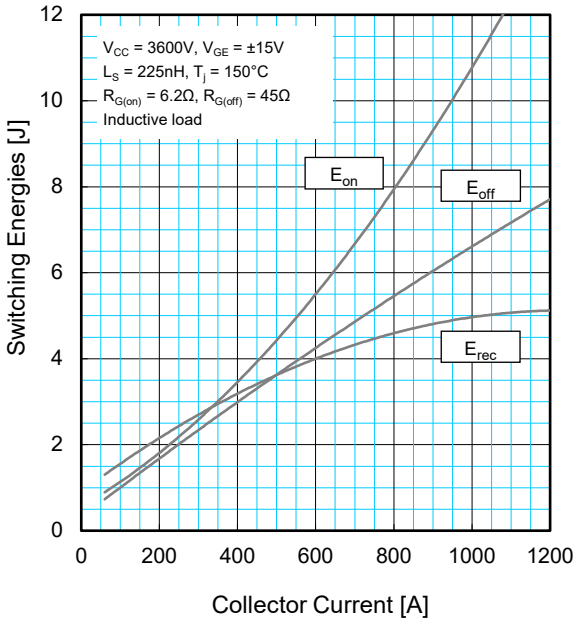
GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

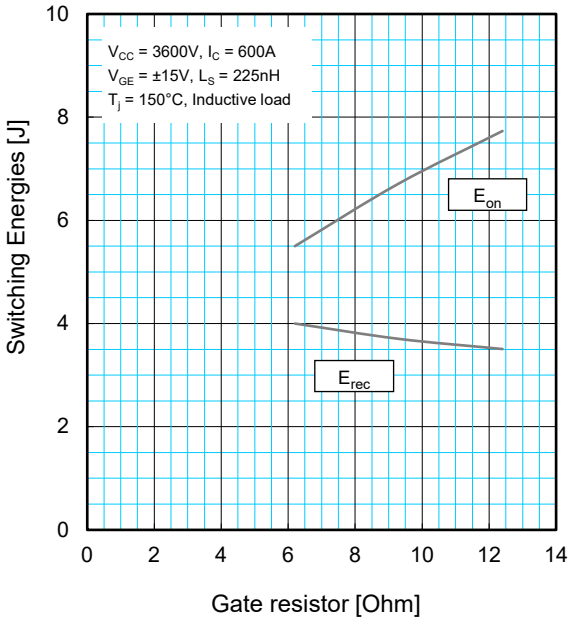


HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

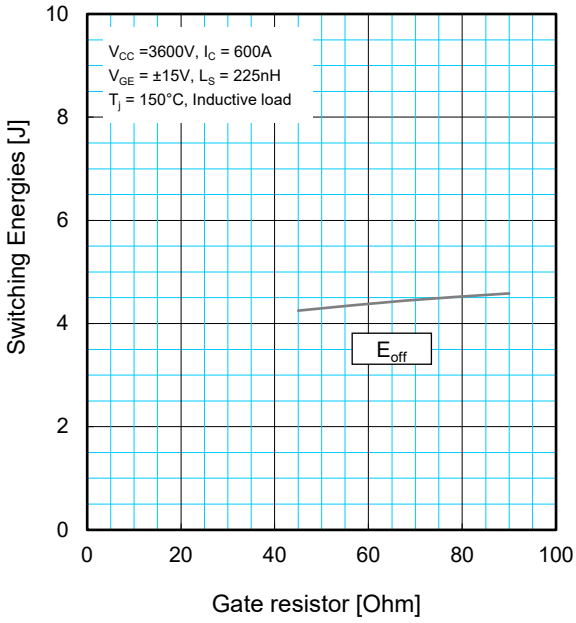


PERFORMANCE CURVES

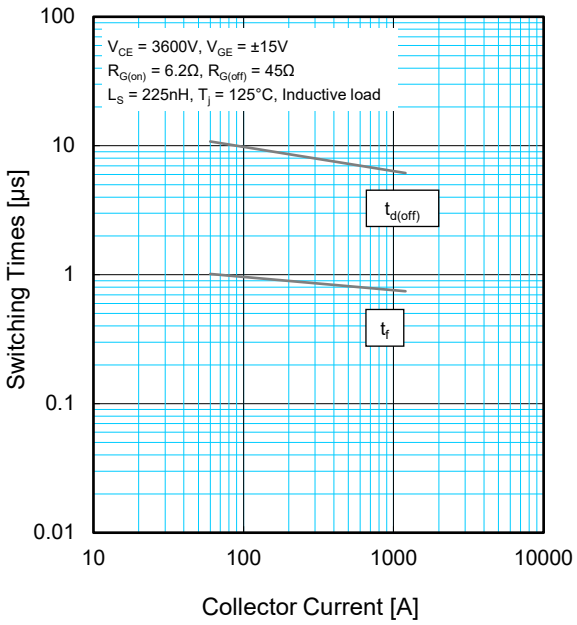
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



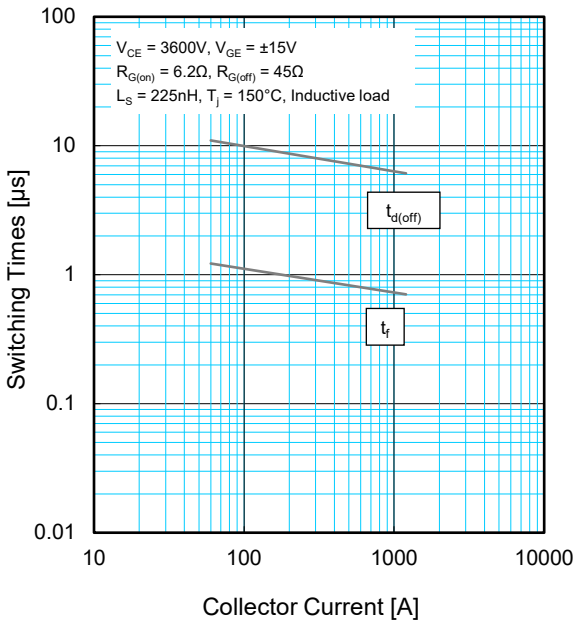
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

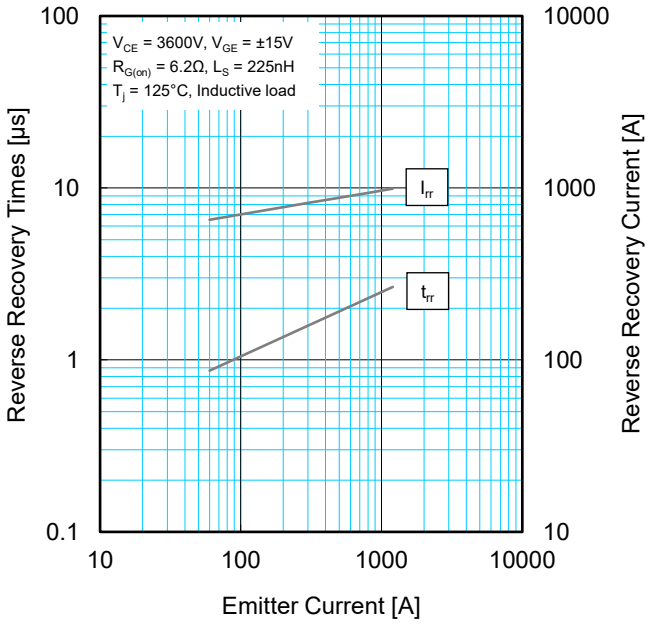


HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

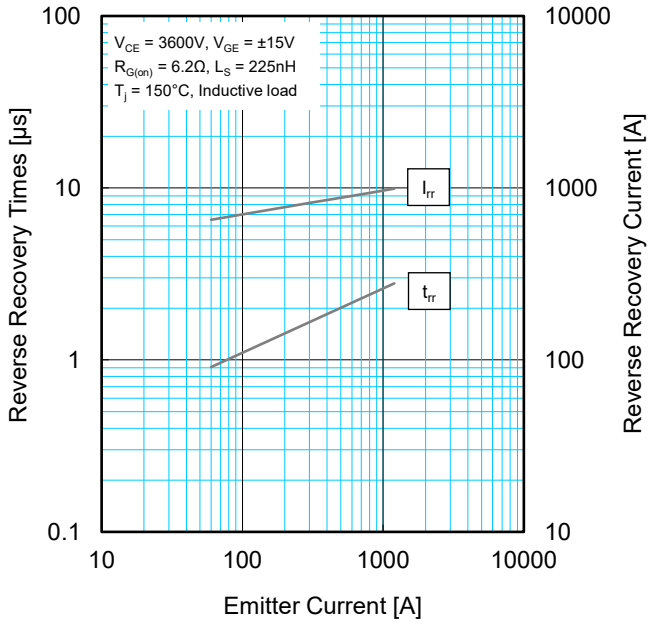


PERFORMANCE CURVES

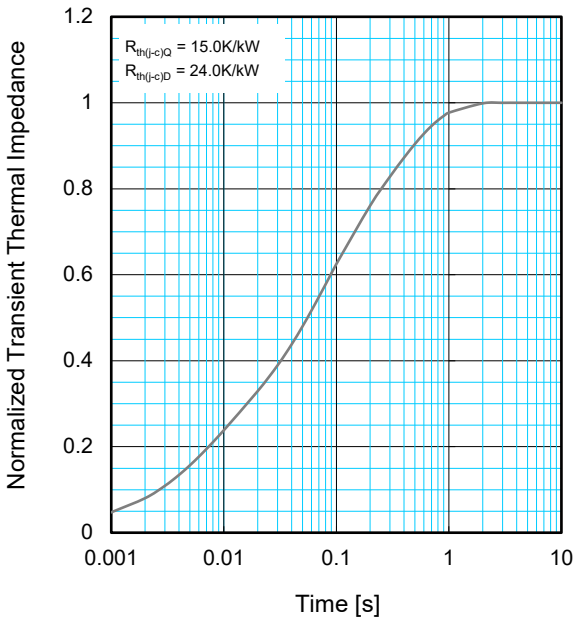
FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS

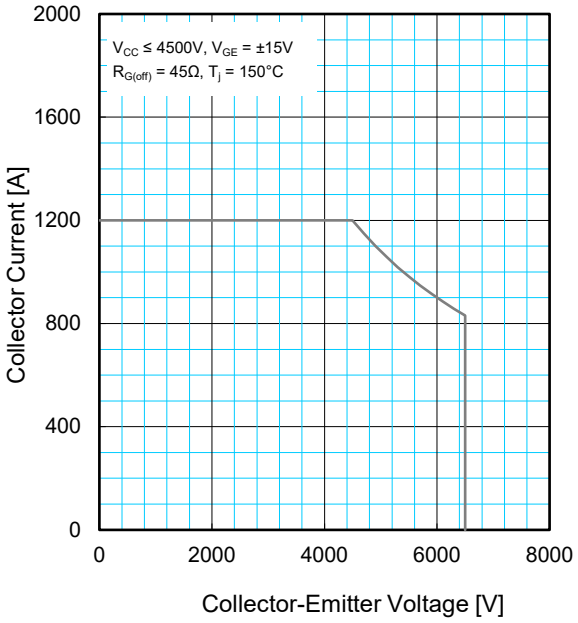


$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_i \left\{ 1 - exp^{\left(-\frac{t}{\tau_i}\right)} \right\}$$

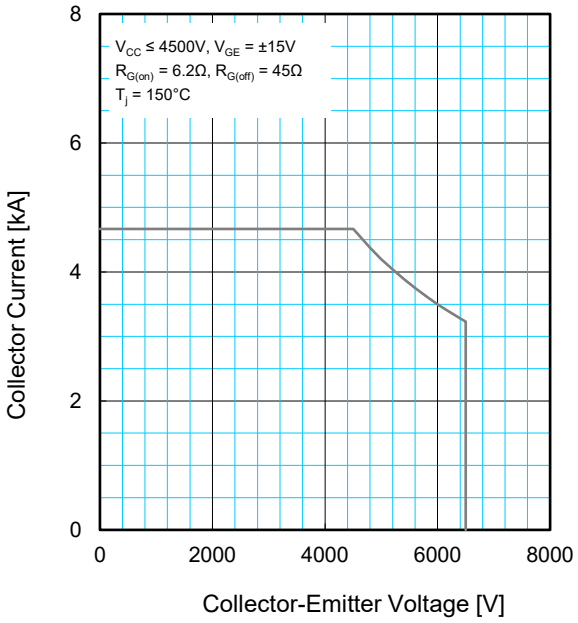
	1	2	3	4
R_i / $R_{th(j-c)}$	0.0096	0.1893	0.4044	0.3967
τ_i [s]	0.0001	0.0058	0.0602	0.3512

PERFORMANCE CURVES

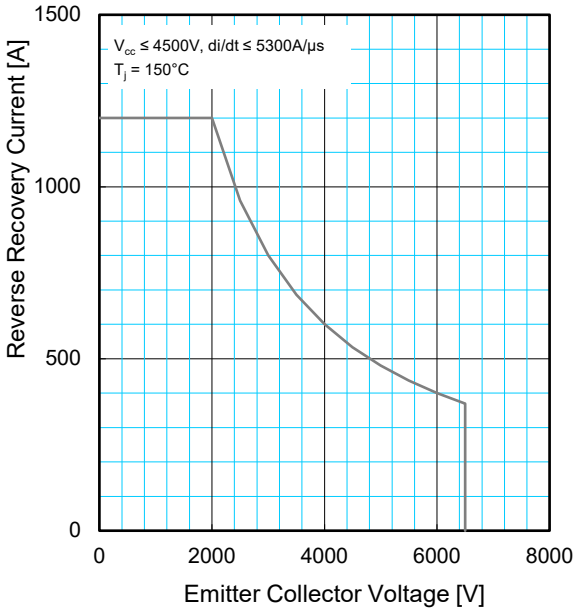
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



Important Notice

The information contained in this datasheet shall in no event be regarded as a guarantee of conditions or characteristics. This product has to be used within its specified maximum ratings, and is subject to customer's compliance with any applicable legal requirement, norms and standards.

Except as otherwise explicitly approved by Mitsubishi Electric Corporation in a written document signed by authorized representatives of Mitsubishi Electric Corporation, our products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

In usage of power semiconductor, there is always the possibility that trouble may occur with them by the reliability lifetime such as Power Cycle, Thermal Cycle or others, or when used under special circumstances (e.g. condensation, high humidity, dusty, salty, highlands, environment with lots of organic matter / corrosive gas / explosive gas, or situations which terminals of semiconductor products receive strong mechanical stress). Therefore, please pay sufficient attention to such circumstances. Further, depending on the technical requirements, our semiconductor products may contain environmental regulation substances, etc. If there is necessity of detailed confirmation, please contact our nearest sales branch or distributor.

The contents or data contained in this datasheet are exclusively intended for technically trained staff. Customer's technical departments should take responsibility to evaluate the suitability of Mitsubishi Electric Corporation product for the intended application and the completeness of the product data with respect to such application. In the customer's research and development, please evaluate it not only with a single semiconductor product but also in the entire system, and judge whether it's applicable. As required, pay close attention to the safety design by installing appropriate fuse or circuit breaker between a power supply and semiconductor products to prevent secondary damage. Please also pay attention to the application note and the related technical information.

Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

Notes regarding these materials

- These materials are intended as a reference to assist our customers in the selection of the Mitsubishi Electric Semiconductor product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Mitsubishi Electric Corporation or a third party.
- Mitsubishi Electric Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Mitsubishi Electric Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for the latest product information before purchasing a product listed herein.
  The information described here may contain technical inaccuracies or typographical errors. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.
  Please also pay attention to information published by Mitsubishi Electric Corporation by various means, including the Mitsubishi Electric Semiconductor home page
  (https://www.MitsubishiElectric.com/semiconductors/).
- When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- Mitsubishi Electric Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- The prior written approval of Mitsubishi Electric Corporation is necessary to reprint or reproduce in whole or in part these materials.
- If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.
  Any diversion or re-export contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for further details on these materials or the products contained therein.